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U.S. PATENT DOCUMENTS							
Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		

	FOREIGN PATENT DOCUMENTS								
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Examiner	Cite	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of	T2				
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11	NFORMATION	N DI	SCLOSURE	Filing Date	March 23, 2006	
S	TATEMENT I	3Y /	APPLICANT	First Named Inventor	Shimon Weiss	
				Art Unit	1792	
	(Use as many sh	eets as	necess ary)	Examiner Name	Elena Tsoy Lightfoot	
Sheet	3	of	3	Attorney Docket Number 58086-229105		

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